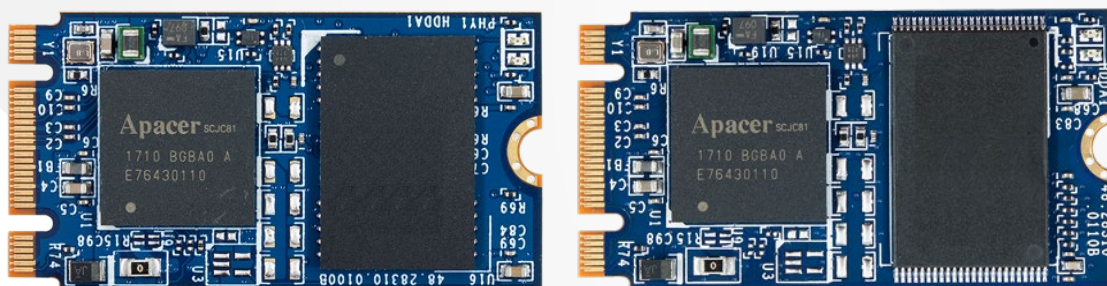


## RoHS Recast Compliant M.2 2242 Flash Drive

### Industrial SU230-M242 Product Specifications



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Version 1.6



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## Specifications Overview:

- **Compliance with SATA Revision 3.2**
  - SATA 6 Gb/s interface
  - ATA-8 command set
  - Backward compatible with SATA 1.5/3 Gb/s
- **Capacity**
  - 4, 8, 16, 32, 64, 128 GB
- **Performance<sup>1</sup>**
  - Burst read/write: 600 MB/sec
  - Sequential read: Up to 555 MB/sec
  - Sequential write: Up to 475 MB/sec
  - Random read (4K): Up to 40,000 IOPS
  - Random write (4K): Up to 58,000 IOPS
- **Flash Management**
  - Built-in hardware ECC
  - Global Wear Leveling
  - Flash bad-block management
  - Flash Translation Layer: Page Mapping
  - S.M.A.R.T.
  - Power Failure Management
  - Device Sleep (optional)
  - ATA Secure Erase
  - TRIM
  - SMART Read Refresh™
- **NAND Flash Type: MLC**
- **Firmware Version: SLC-lite**
- **MTBF: >1,000,000 hours**
- **Endurance (in Terabytes Written: TBW)**
  - 4 GB: 30 TBW
  - 8 GB: 89 TBW
  - 16 GB: 148 TBW
  - 32 GB: 336 TBW
  - 64 GB: 757 TBW
  - 128 GB: 1,515 TBW
- **Temperature Range**
  - Operating:
    - Standard: 0°C to 70°C
    - Wide: -40°C to 85°C
  - Storage: -55°C to 100°C
- **Supply Voltage**
  - 3.3V ± 5%
- **Power Consumption<sup>1</sup>**
  - Active mode (Max.): 720 mA
  - Idle mode: 125 mA
- **Connector Type**
  - M.2 B & M Key
- **Form Factor**
  - Double-sided: M.2 2242-D5-B-M
  - Dimensions: 42.00 x 22.00 x 3.88<sub>(max.)</sub>, unit: mm
- **Reliability**
  - Thermal Sensor
  - Thermal Management Technique (optional)
- **LED Indicators for Drive Behavior**
- **RoHS Recast Compliant (Complies with 2011/65/EU Standard)**

Note:

1. Varies from capacities. The values for performances and power consumptions presented are typical and may vary depending on flash configurations or platform settings. The term idle refers to the standby state of the device.

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## 1. General Description

Apacer's SU230-M242 (M.2 2242) is the next generation modularized Solid State Drive (SSD) with the shape of all new M.2 form factor, with the aim to be the more suitable for mobile and compact computers with standard width at only 22.00 mm. SU230-M242 appears in M.2 2242 mechanical dimensions and is believed to be the leading add-in storage solution for future host computing systems.

The M.2 SSD is designed with SATA-based connector pinouts, providing full compliance with the latest SATA Revision 3.2 interface specifications. Aside from SATA compliance, SU230-M242 delivers exceptional performance and power efficiency. On the other hand, the extreme thin and light form factor makes SU230-M242 the ideal choice for mobile computing systems, which appears to be the trend in near future.

Regarding reliability, SU230-M242 is built with a powerful SATA controller that supports on-the-module ECC as well as efficient wear leveling scheme. Operating under SATA 6 Gb/s interface, SU230-M242 is provided with Apacer latest S.M.A.R.T. that is primarily oriented for the latest SATA interface SSD, for drive lifetime monitoring and analysis. Furthermore, SU230-M242 is equipped with a built-in thermal sensor to monitor the temperature of the SSD via S.M.A.R.T commands to prevent overheating. SU230-M242 also adopts the latest page mapping file translation layer and comes with various implementations including flash block management, power failure management, TRIM, power saving modes, and SMART Read Refresh.

With exceptional performance, trustable reliability and enhanced data protection, SU230-M242 is definitely the ideal storage or cache solution for a variety of applications ranging from industrial, imaging, computing to enterprise markets.

## 2. Functional Block

Apacer SU230-M242 includes a single-chip controller and flash media. The controller integrates the flash management unit to support multi-channel, multi-bank flash arrays. Figure 2-1 shows the functional block diagram.

Note: The actual number of NAND flash used on Apacer SU230-M242 varies from capacities. The illustration is for reference only.

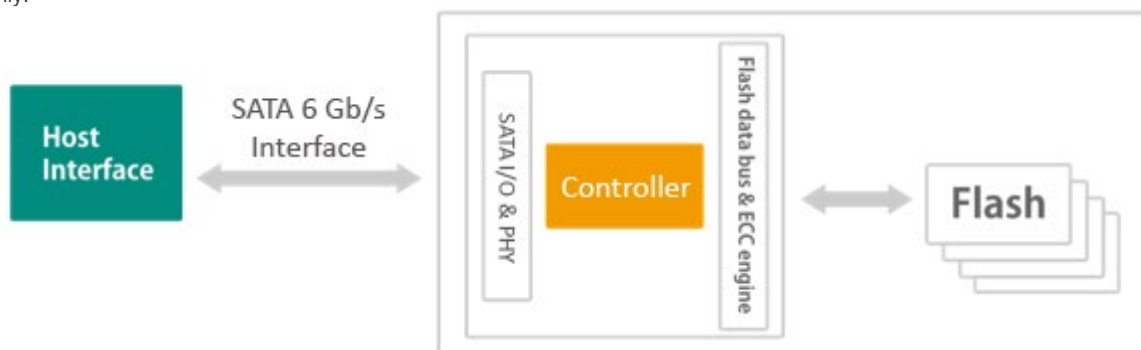


Figure 2-1 Functional Block Diagram

### 3. Pin Assignments

This connector does not support hot plug capability. There are a total of 75 pins. 12 pin locations are used for mechanical key locations; this allows such a module to plug into both Key B and Key M connectors.

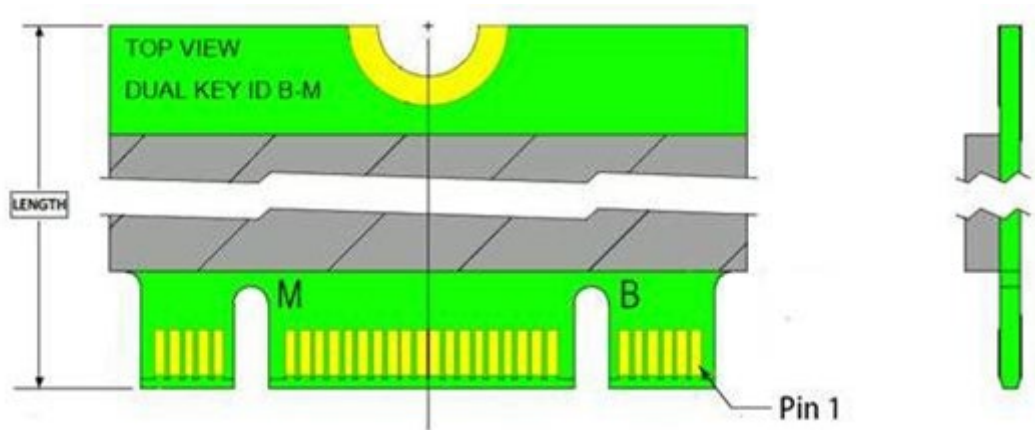


Figure 3-1 SATA Connectors

Table 3-1 Pin Assignments

Pin No.	Type	Description
1	CONFIG_3	Ground (according to M.2 configurations for SSD-SATA definition)
2	3.3V	Supply Pin, 3.3V
3	GND	Ground
4	3.3V	Supply pin, 3.3V
5	No connect	No connect
6	Not available	No connect
7	Not available	No connect
8	Not available	Reserved for Apacer use only <sup>1</sup>
9	No connect	No connect
10	DAS/DSS	Device Activity Signal/Disable Staggered Spin-up
11	No connect	No connect
12	(removed for key)	Mechanical notch B
13	(removed for key)	Mechanical notch B
14	(removed for key)	Mechanical notch B
15	(removed for key)	Mechanical notch B
16	(removed for key)	Mechanical notch B
17	(removed for key)	Mechanical notch B
18	(removed for key)	Mechanical notch B
19	(removed for key)	Mechanical notch B
20	Not available	No connect
21	CONFIG_0	Ground (according to M.2 configurations for SSD-SATA definition)
22	Not available	No connect

Table 3-1 Pin Assignments

Pin No.	Type	Description
23	Not available	No connect
24	Not available	No connect
25	Not available	No connect
26	Not available	No connect
27	GND	Ground
28	Not available	No connect
29	PERn1	No connect
30	Not available	No connect
31	PERp1	No connect
32	Not available	No connect
33	GND	Ground
34	Not available	No connect
35	PETn1	No connect
36	Not available	No connect
37	PETp1	No connect
38	DEVSLP	Device Sleep, input. If driven high the host is informing the SSD to enter a low power state
39	GND	Ground
40	Not available	No connect
41	SATA-Rx+	Host receiver differential signal pair
42	Not available	No connect
43	SATA-Rx-	Host receiver differential signal pair
44	Not available	No connect
45	GND	Ground
46	Not available	No connect
47	SATA-Tx-	Host transmitter differential pair
48	Not available	No connect
49	SATA-Tx+	Host transmitter differential pair
50	PERST#	No connect
51	GND	Ground
52	CLKREQ#	No connect
53	REFCLKN	No connect
54	PEWAKE#	No connect
55	REFCLKP	No connect
56	MFG1	Reserved for Apacer use only <sup>1</sup>
57	GND	Ground
58	MFG2	Reserved for Apacer use only <sup>1</sup>
59	(removed for key)	Mechanical notch M
60	(removed for key)	Mechanical notch M
61	(removed for key)	Mechanical notch M
62	(removed for key)	Mechanical notch M

Table 3-1 Pin Assignments

Pin No.	Type	Description
63	(removed for key)	Mechanical notch M
64	(removed for key)	Mechanical notch M
65	(removed for key)	Mechanical notch M
66	(removed for key)	Mechanical notch M
67	Not available	No connect
68	SUSCLK	No connect
69	CONFIG_1	Ground
70	3.3V	Supply pin, 3.3V
71	GND	Ground
72	3.3V	Supply pin, 3.3V
73	GND	Ground
74	3.3V	Supply pin, 3.3V
75	CONFIG_2	Ground

Note:

1. Reserved by Apacer, please do not connect to a host.

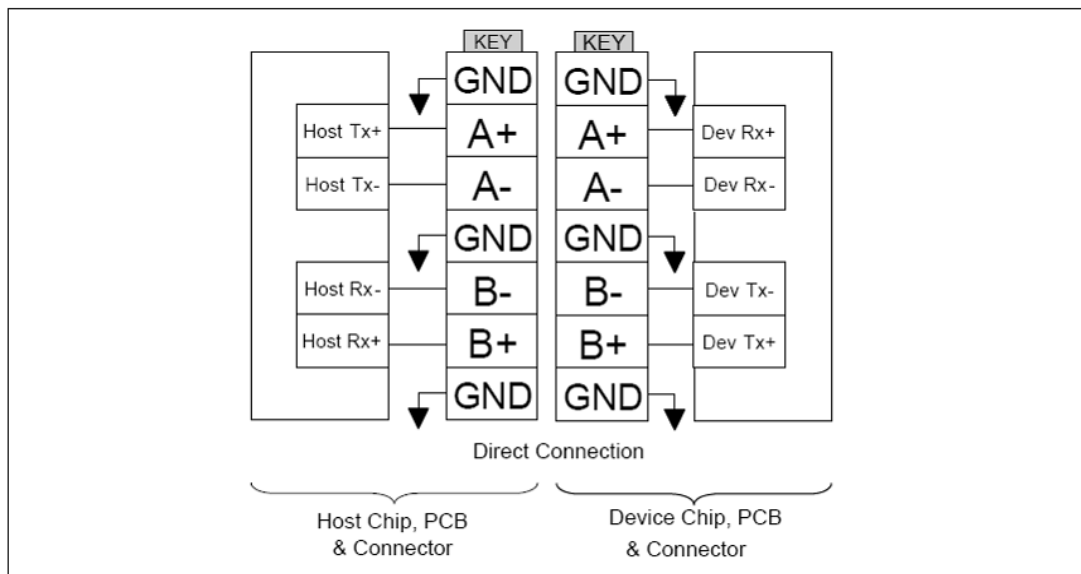


Figure 3-2 Direct Connection between the Host and Device

## 4. Product Specifications

### 4.1 Capacity

Capacity specifications of SU230-M242 are available as shown in Table 4-1. It lists the specific capacity and the default numbers of heads, sectors and cylinders for each product line.

**Table 4-1 Capacity Specifications**

Capacity	Total bytes	Cylinders	Heads	Sectors	Total LBA
4 GB	4,011,614,208	7,773	16	63	7,835,184
8 GB	8,012,390,400	15,525	16	63	15,649,200
16 GB	16,013,942,784	16,383	16	63	31,277,232
32 GB	32,017,047,552	16,383	16	63	62,533,296
64 GB	64,023,257,088	16,383	16	63	125,045,424
128 GB	128,035,676,160	16,383	16	63	250,069,680

Notes:

- Display of total bytes varies from operating systems.
- 1 GB = 1,000,000,000 bytes; 1 sector = 512 bytes.
- LBA count addressed in the table above indicates total user storage capacity and will remain the same throughout the lifespan of the device. However, the total usable capacity of the SSD is most likely to be less than the total physical capacity because a small portion of the capacity is reserved for device maintenance usages.

### 4.2 Performance

Performance of SU230-M242 is listed below in Table 4-2.

**Table 4-2 Performance Specifications**

Capacity	4 GB	8 GB	16 GB	32 GB	64 GB	128 GB
<b>Performance</b>						
<b>Sequential Read (MB/s)</b>	140	280	285	285	555	555
<b>Sequential Write (MB/s)</b>	65	85	120	230	470	475
<b>4K Random Read (IOPS)</b>	8,000	16,000	15,000	26,000	40,000	40,000
<b>4K Random Write (IOPS)</b>	2,000	5,000	10,000	20,000	36,000	58,000

Notes:

- Results may differ from various flash configurations or host system setting.
- Sequential read/write is based on CrystalDiskMark 5.2.1 with file size 1,000MB.
- Random read/write is measured using IOMeter with Queue Depth 32.

### 4.3 Environmental Specifications

Environmental specifications of SU230-M242 product are shown in Table 4-3.

**Table 4-3 Environmental Specifications**

Parameter	Type	Specifications
Temperature	Operating	0°C to 70°C (Standard); -40°C to 85°C (Wide)
	Non-operating	-55°C to 100°C
Vibration	Operating	7.69 GRMS, 20~2000 Hz/random (compliant with MIL-STD-810G)
	Non-operating	4.02 GRMS, 15~2000 Hz/random (compliant with MIL-STD-810G)
Shock	Operating	Acceleration, 50(G)/11(ms)/half sine (compliant with MIL-STD-202G)
	Non-operating	Acceleration, 1500(G)/0.5(ms)/half sine (compliant with MIL-STD-883K)

Note: This Environmental Specification table indicates the conditions for testing the device. Real world usages may affect the results.

### 4.4 Mean Time Between Failures (MTBF)

Mean Time Between Failures (MTBF) is predicted based on reliability data for the individual components in SU230-M242. The prediction result for SU230-M242 is more than 1,000,000 hours.

Note: The MTBF is predicated and calculated based on “Telcordia Technologies Special Report, SR-332, Issue 3” method.

### 4.5 Certification and Compliance

SU230-M242 complies with the following standards:

- CE
- UKCA
- FCC
- RoHS Recast
- MIL-STD-810G

## 4.6 Endurance

The endurance of a storage device is predicted by TeraBytes Written based on several factors related to usage, such as the amount of data written into the drive, block management conditions, and daily workload for the drive. Thus, key factors, such as Write Amplifications and the number of P/E cycles, can influence the lifespan of the drive.

**Table 4-4 Endurance Specifications**

Capacity	TeraBytes Written
4 GB	30
8 GB	89
16 GB	148
32 GB	336
64 GB	757
128 GB	1,515

Notes:

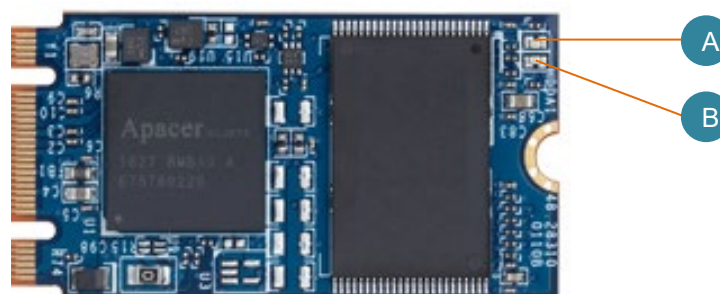
- This estimation complies with JEDEC JESD-219, enterprise endurance workload of random data with payload size distribution.
- Flash vendor guaranteed SLC-lite P/E cycle: 20K
- WAF may vary from capacity, flash configurations and writing behavior on each platform.
- 1 Terabyte = 1,024GB

## 4.7 LED Indicator Behavior

The behavior of the SU230-M242 LED indicators is described in Table 4-5.

**Table 4-5 LED Behavior**

Location	LED	Description
LED A	PHY	LED blinks when PHY is connected
LED B	DAS	LED blinks when the drive is being accessed



## 5. Flash Management

### 5.1 Error Correction/Detection

SU230-M242 implements a hardware ECC scheme, based on the BCH algorithm. It can detect and correct up to 76 bits error in 1K bytes.

### 5.2 Bad Block Management

Current production technology is unable to guarantee total reliability of NAND flash memory array. When a flash memory device leaves factory, it comes with a minimal number of initial bad blocks during production or out-of-factory as there is no currently known technology that produce flash chips free of bad blocks. In addition, bad blocks may develop during program/erase cycles. Since bad blocks are inevitable, the solution is to keep them in control. Apacer flash devices are programmed with ECC, page mapping technique and S.M.A.R.T to reduce invalidity or error. Once bad blocks are detected, data in those blocks will be transferred to free blocks and error will be corrected by designated algorithms.

### 5.3 Global Wear Leveling

Flash memory devices differ from Hard Disk Drives (HDDs) in terms of how blocks are utilized. For HDDs, when a change is made to stored data, like erase or update, the controller mechanism on HDDs will perform overwrites on blocks. Unlike HDDs, flash blocks cannot be overwritten and each P/E cycle wears down the lifespan of blocks gradually. Repeatedly program/erase cycles performed on the same memory cells will eventually cause some blocks to age faster than others. This would bring flash storages to their end of service term sooner. Global wear leveling is an important mechanism that levels out the wearing of all blocks so that the wearing-down of all blocks can be almost evenly distributed. This will increase the lifespan of SSDs.

### 5.4 Power Failure Management

Power Failure Management plays a crucial role when power supply becomes unstable. Power disruption may occur when users are storing data into the SSD, leading to instability in the drive. However, with Power Failure Management, a firmware protection mechanism will be activated to scan pages and blocks once power is resumed. Valid data will be transferred to new blocks for merging and the mapping table will be rebuilt. Therefore, data reliability can be reinforced, preventing damage to data stored in the NAND Flash.

### 5.5 ATA Secure Erase

ATA Secure Erase is an ATA disk purging command currently embedded in most of the storage drives. Defined in ATA specifications, (ATA) Secure Erase is part of Security Feature Set that allows storage drives to erase all user data areas. The erase process usually runs on the firmware level as most of the ATA-based storage media currently in the market are built-in with this command. ATA Secure Erase can securely wipe out the user data in the drive and protects it from malicious attack.

## 5.6 TRIM

TRIM is a SATA command that helps improve the read/write performance and efficiency of solid-state drives (SSD). The command enables the host operating system to inform SSD controller which blocks contain invalid data, mostly because of the erase commands from host. The invalid will be discarded permanently and the SSD will retain more space for itself.

## 5.7 Flash Translation Layer – Page Mapping

Page mapping is an advanced flash management technology whose essence lies in the ability to gather data, distribute the data into flash pages automatically, and then schedule the data to be evenly written. Page-level mapping uses one page as the unit of mapping. The most important characteristic is that each logical page can be mapped to any physical page on the flash memory device. This mapping algorithm allows different sizes of data to be written to a block as if the data is written to a data pool and it does not need to take extra operations to process a write command. Thus, page mapping is adopted to increase random access speed and improve SSD lifespan, reduce block erase frequency, and achieve optimized performance and lifespan.

## 5.8 Device Sleep (DevSleep or DEVSLP) Mode (optional)

Device Sleep is a feature that allows SATA devices to enter a low power mode by designating a particular pin as DEVSLP signal with an aim to reducing power consumption.



Parameter	Description & Conditions	Min	Max
V <sub>DIn</sub>	Tolerated input voltage.	-0.5 V	3.6 V
V <sub>HAssert</sub>	Voltage presented to host if signal not driven low. Value specified for all allowable I <sub>HAssert</sub> .	-	2.4 V
I <sub>HNegate</sub>	Device current delivered to host if host driving signal low. Value specified at V <sub>HNegate</sub> voltage of 0 V.	-	100 µA

## 5.9 SMART Read Refresh™

Apacer's SMART Read Refresh plays a proactive role in avoiding read disturb errors from occurring to ensure health status of all blocks of NAND flash. Developed for read-intensive applications in particular, SMART Read Refresh is employed to make sure that during read operations, when the read operation threshold is reached, the data is refreshed by re-writing it to a different block for subsequent use.

## 5.10 SATA Power Management

By complying with SATA 6 Gb/s specifications, the SSD supports the following SATA power saving modes:

- ACTIVE: PHY ready, full power, Tx & Rx operational
- PARTIAL: Reduces power, resumes in under 10  $\mu$ s (microseconds)
- SLUMBER: Reduces power, resumes in under 10 ms (milliseconds)
- HIPM: Host-Initiated Power Management
- DIPM: Device-Initiated Power Management
- AUTO-SLUMBER: Automatic transition from partial to slumber.
- Device Sleep (DevSleep or DEVSLP): PHY powered down; power consumption  $\leq$  5 mW; host assertion time  $\leq$  10 ms; exit timeout from this state  $\leq$  20 ms (unless specified otherwise in SATA Identify Device Log).

Notes:

1. The behaviors of power management features would depend on host/device settings.
2. Device Sleep mode is optional, depending on product ordering selections.

## 6. Reliability Features

### 6.1 Thermal Sensor

Apacer Thermal Sensor is a digital temperature sensor with serial interface. By using designated pins for transmission, storage device owners are able to read temperature data.

### 6.2 Thermal Management Technique (optional)

Thermal management technique can monitor the temperature of the SSD equipped with a built-in thermal sensor via S.M.A.R.T. commands. This method can ensure the temperature of the device stays within temperature limits by drive throttling, i.e. reducing the speed of the drive when the device temperature reaches the threshold level, so as to prevent overheating, guarantee data reliability, and prolong product lifespan. When the temperature exceeds the maximum threshold level, thermal throttling will be triggered to reduce performance step by step to prevent hardware components from being damaged. Performance is only permitted to drop to the extent necessary for recovering a stable temperature to cool down the device's temperature. Once the temperature decreases to the minimum threshold value, transfer speeds will rise back to its optimum performance level.

## 7. Software Interface

### 7.1 Command Set

This section defines the software requirements and the format of the commands the host sends to SU230-M242. Commands are issued to SU230-M242 by loading the required registers in the command block with the supplied parameters, and then writing the command code to the Command register.

Table 7-1 Command Set

Code	Command	Code	Command
E5h	CHECK POWER MODE	F4h	SECURITY ERASE UNIT
06h	DATA SET MANAGEMENT	F5h	SECURITY FREEZE LOCK
92h	DOWNLOAD MICROCODE	F1h	SECURITY SET PASSWORD
90h	EXECUTE DEVICE DIAGNOSTIC	F2h	SECURITY UNLOCK
E7h	FLUSH CACHE	70h	SEEK
EAh	FLUSH CACHE EXT	EFh	SET FEATURES
ECh	IDENTIFY DEVICE	C6h	SET MULTIPLE MODE
E3h	IDLE	E6h	SLEEP
E1h	IDLE IMMEDIATE	B0h	SMART
91h	INITIALIZE DEVICE PARAMETERS	E2h	STANDBY
E4h	READ BUFFER	E0h	STANDBY IMMEDIATE
C8h	READ DMA	E8h	WRITE BUFFER
25h	READ DMA EXT	CAh	WRITE DMA
60h	READ FPDMA QUEUED	35h	WRITE DMA EXT
C4h	READ MULTIPLE	3Dh	WRITE DMA FUA EXT
29h	READ MULTIPLE EXT	61h	WRITE FPDMA QUEUED
2Fh	READ LOG EXT	3Fh	WRITE LOG EXT
47h	READ LOG DMA EXT	57h	WRITE LOG DMA EXT
20h	READ SECTOR	C5h	WRITE MULTIPLE
24h	READ SECTOR EXT	39h	WRITE MULTIPLE EXT
40h	READ VERIFY SECTORS	CEh	WRITE MULTIPLE FUA EXT
42h	READ VERIFY SECTORS EXT	30h	WRITE SECTOR
10h	RECALIBRATE	34h	WRITE SECTOR EXT
F6h	SECURITY DISABLE PASSWORD	45h	WRITE UNCORRECTABLE EXT
F3h	SECURITY ERASE PREPARE		

## 7.2 S.M.A.R.T.

SMART, an acronym for Self-Monitoring, Analysis and Reporting Technology, is an open standard that allows a hard disk drive to automatically detect its health and report potential failures. When a failure is recorded by SMART, users can choose to replace the drive to prevent unexpected outage or data loss. Moreover, SMART can inform users of impending failures while there is still time to perform proactive actions, such as copy data to another device.

**Table 7-2 SMART Subcommand Set**

Code	SMART Subcommand
D0h	READ DATA
D1h	READ ATTRIBUTE THRESHOLDS
D2h	ENABLE/DISABLE ATTRIBUTE AUTOSAVE
D4h	EXECUTE OFF-LINE IMMEDIATE
D5h	SMART READ LOG
D6h	SMART WRITE LOG
D8h	ENABLE OPERATIONS
D9h	DISABLE OPERATIONS
DAh	RETURN STATUS

**Table 7-3 General SMART Attribute Structure**

Bytes	Description
0	ID (Hex)
1 – 2	Status Flag
3	Value
4	Worst
5*-11	Raw Data

\*Byte 5: LSB

**Table 7-4 SMART Attribute ID List**

ID (Hex)	Attribute Name
9 (0x09)	Power-on Hours
12 (0x0C)	Power Cycle Count
163 (0xA3)	Maximum Erase Count
164 (0xA4)	Average Erase Count
166 (0xA6)	Total Later Bad Block Count
167 (0xA7)	SSD Protect Mode (Vendor Specific)
168 (0xA8)	SATA PHY Error Count
171 (0xAB)	Program Fail Count
172 (0xAC)	Erase Fail Count
175 (0xAF)	Bad Cluster Table Count
192 (0xC0)	Unexpected Power Loss Count
194 (0xC2)	Temperature
231 (0xE7)	Lifetime Left
241 (0xF1)	Total Sectors of Write

## 8. Electrical Specifications

### 8.1 Operating Voltage

Table 8-1 lists the supply voltage for SU230-M242.

**Caution: Absolute Maximum Stress Ratings** – Applied conditions greater than those listed under “Absolute Maximum Stress Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these conditions or conditions greater than those defined in the operational sections of this data sheet is not implied. Exposure to absolute maximum stress rating conditions may affect device reliability.

**Table 8-1 Operating Range**

Item	Range
Supply Voltage	3.3V ± 5% (3.135-3.465V)

### 8.2 Power Consumption

Table 8-2 lists the power consumption for SU230-M242.

**Table 8-2 Power Consumption**

Mode \ Capacity	Unit	4 GB	8 GB	16 GB	32 GB	64 GB	128 GB
Active (Max.)	mA	395	470	455	520	700	720
Idle		125	125	120	120	120	120

Notes:

- All values are typical and may vary depending on flash configurations or host system settings.
- Power consumption is measured using CrystalDiskMark 5.2.1 with file size 1,000MB.

## 9. Mechanical Specifications

Table 9-1 Physical Dimensions

Parameter	Unit	4 GB	8 GB	16 GB	32 GB	64 GB	128 GB
Length	mm	42.00 ± 0.15					
Width		22.00 ± 0.15					
Height (Max.)		3.88					

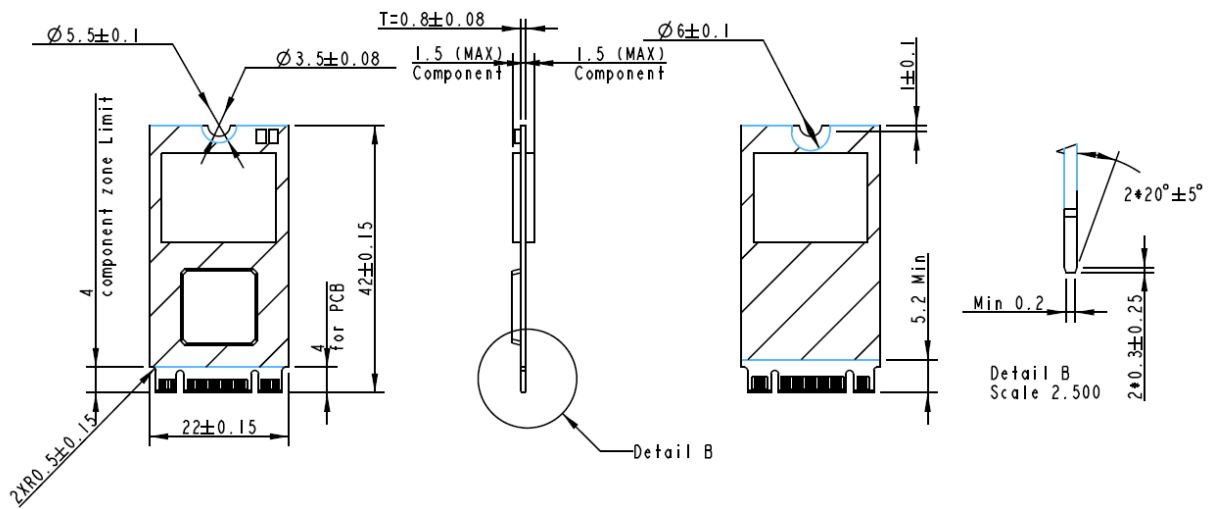
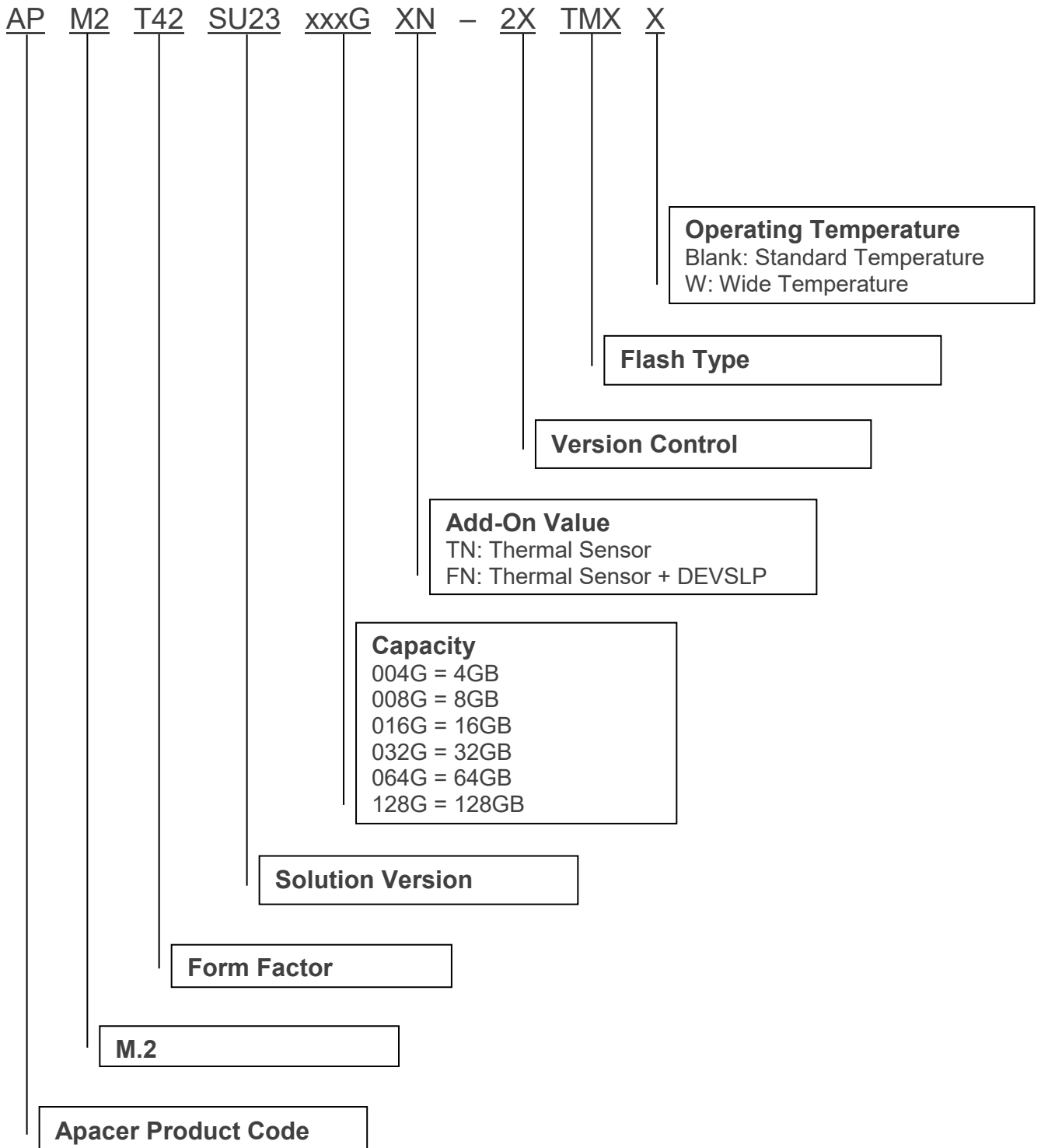


Figure 9-1 Physical Dimensions

## 10. Product Ordering Information

### 10.1 Product Code Designations



## 10.2 Valid Combinations

The following tables list the available models of the SU230-M242 series which are in mass production or will be in mass production. Consult your Apacer sales representative to confirm availability of valid combinations and to determine availability of new combinations.

### 10.2.1 Without DEVSLP

Capacity	Standard Temperature	Wide Temperature
4GB	APM2T42SU23004GTN-2CTM	APM2T42SU23004GTN-2CTMW
8GB	APM2T42SU23008GTN-2CTM	APM2T42SU23008GTN-2CTMW
16GB	APM2T42SU23016GTN-2CTM	APM2T42SU23016GTN-2CTMW
32GB	APM2T42SU23032GTN-2CTMG	APM2T42SU23032GTN-2CTMGW
64GB	APM2T42SU23064GTN-2CTMG	APM2T42SU23064GTN-2CTMGW
128GB	APM2T42SU23128GTN-2CTMG	APM2T42SU23128GTN-2CTMGW

### 10.2.2 With DEVSLP (optional)

Capacity	Standard Temperature	Wide Temperature
4GB	APM2T42SU23004GFN-2DTM	APM2T42SU23004GFN-2DTMW
8GB	APM2T42SU23008GFN-2DTM	APM2T42SU23008GFN-2DTMW
16GB	APM2T42SU23016GFN-2DTM	APM2T42SU23016GFN-2DTMW
32GB	APM2T42SU23032GFN-2DTMG	APM2T42SU23032GFN-2DTMGW
64GB	APM2T42SU23064GFN-2DTMG	APM2T42SU23064GFN-2DTMGW
128GB	APM2T42SU23128GFN-2DTMG	APM2T42SU23128GFN-2DTMGW

## Revision History

Revision	Description	Date
0.1	Preliminary release	7/25/2018
1.0	Updated Endurance on Specifications Overview page and 4.6 Endurance	7/31/2018
1.1	<ul style="list-style-type: none"> <li>- Renamed extended temperature to wide temperature</li> <li>- Renamed Power Failure Management to DataDefender at Flash Management on Specifications Overview page and 5.4 section and updated the technology description</li> <li>- Added 4.7 LED Indicator Behavior</li> </ul>	2/19/2019
1.2	Updated valid combinations for 10.2.2 With DEVSLP (optional)	3/7/2019
1.3	<ul style="list-style-type: none"> <li>- Added SMART Read Refresh to Flash Management on Specifications Overview page</li> <li>- Changed SATA 6.0 Gbps to SATA 6 Gb/s in accordance with SATA naming guidelines</li> <li>- Added 5.11 SMART Read Refresh</li> <li>- Capitalized every letter for commands at 7.1 Command Set and SMART subcommand at 7.2 S.M.A.R.T.</li> </ul>	5/15/2020
1.4	<ul style="list-style-type: none"> <li>- Updated compliance version with SATA Interface from 3.1 to 3.2 on Specifications Overview page</li> <li>- Replaced DataDefender with Power Failure Management on Specifications Overview page</li> <li>- Updated Table 4-1 by changing max LBA to total LBA</li> <li>- Modified the issue version for the note at 4.4 Mean Time Between Failures (MTBF)</li> <li>- Updated the notes for 4.6 Endurance</li> </ul>	6/16/2020
1.5	Updated the description of 5.2 Bad Block Management	6/19/2020
1.6	<ul style="list-style-type: none"> <li>- Removed Hyper Cache Technology information</li> <li>- Updated storage temperature to -55°C to 100°C</li> <li>- Added UKCA to 4.5 Certification and Compliance</li> </ul>	8/24/2023

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